

Notice of References Cited

<u> </u>		
Application/Control No.	Applicant(s)/Pater	nt Under
10/066,631	Reexamination ANTTILA ET AL.	
Examiner	Art Unit	
KIEU-OANH TBUI	2611	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2001/0030664 A1	10-2001	Shulman et al.	345
	В	US-5,930,700	07-1999	Pepper et al.	455
	С	US-6,381,465 B1	04-2002	Chern et al.	466
	D	US-2003/0093789 A1	05-2003	Zimmmerman et al.	725
	E	US-2003/0028884 A1	02-2003	Swart et al.	725
	F	US-2003/0061611 A1	03-2003	Pendakur	725
	G	US-2002/0124252 A1	09-2002	Schaefer et al.	725
	Н	US-2002/0199183 A1	12-2002	Tanighuchi	725
	ı	US-2003/0040293 A1	02-2003	Fish et al.	455
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	α					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.